

Notice of References Cited

Application/Control No.

10/710,767

Applicant(s)/Patent Under
Reexamination
CHIEN ET AL.

Examiner

YEU-TZER CHOU

Art Unit

2624

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,704,026	12-1997	Wan, Shijie J.	345/590
*	B	US-5,504,821	04-1996	Kanamori et al.	382/167
*	C	US-2002/0033957	03-2002	Takahata et al.	358/1.9
*	D	US-2003/0099394	05-2003	Shimazawa, Yohichi	382/164
*	E	US-6,480,624	11-2002	Horie et al.	382/165
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.